



<b>Form PTO-1449 Modified</b>  List of Patent and Publications Cited by Applicant (Use several sheets if necessary)  U.S. Department of Commerce Patent and Trademark Office	Docket No. <b>UDL-0004</b>	Application No. <b>10/782,475</b>
	Applicant <b>Graham Heeks, et al.</b>	
	Filing Date <b>February 19, 2004</b>	Group <b>Not Yet Assigned</b>

### U. S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass
<i>SMW</i>	1	4,203,685	05/20/80	Sanchez	404	6
	2	4,362,424	12/07/82	Barber	404	6
	3	4,367,975	01/11/83	Tyers	404	6
	4	4,534,673	08/13/85	May	404	16
	5	5,415,493	05/16/95	Eaton	404	15
	6	5,419,652	05/30/95	Flanders	404	15
	7	6,024,510	02/15/00	Kamienchick	404	15
	8	6,010,277	01/04/00	Follman	404	11
↓	9	3,720,181	03/13/73	Elkins	116	63P
<i>SMW</i>	10	6,276,667 B1	08/21/01	Arthur	256	13.1

### FOREIGN PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Country	Translation	
					YES	NO
<i>SMW</i>	11	2 288 419 A	10/18/1995	Great Britain		
<i>SMW</i>	12	0 370 154 A1	05/30/1990	EPO		
<i>SMW</i>	13	DE 29 14 708	10/23/1980	Germany		X
<i>SMW</i>	14	DE 3 447 712 A1	08/14/86	Germany	X (abstract)	
<i>SMW</i>	15	<del>DE</del> 2 266 552 A	11/03/93	Great Britain		
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	17	WO 91/63051	08/30/01	PCT		
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EXAMINER <i>3. Hopperle</i>				DATE CONSIDERED <i>3/05</i>		

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Examiner Initial		Document No.	Date	Name	Class	Subclass	
<i>SM</i>	19	6,659,682 B2	12/09/03	Heeks, et al.	404	15	
↓	20	6,241,419	06/01	Bond, Michael L.	404	10	
↓	21	2002/0085881	07/02	Heeks, Graham	404	15	
<i>SM</i>	22	2003/0053860	03/03	Hall, Brett Osmund	404	15	
<b>FOREIGN PATENT DOCUMENTS</b>							
Examiner Initial		Document No.	Date	Country	Translation		
					YES	NO	
<i>SM</i>	23	FR 2 622 034	04/21/89	France		X	
<i>SM</i>	24	FR 2 699 567	06/24/94	France		X	
	25	KR 0 020 924	04/00	Korea(SOUTH)			
<i>SM</i>	26	GB 2 324 326	10/21/98	Great Britain			
<i>SM</i>	27	WO 98/40563	09/17/98	PCT			
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EXAMINER <i>S Hepperle</i>				DATE CONSIDERED <i>3/05</i>			